4th International Beam Instrumentation Conference (IBIC) 2015 COMPACT AND COMPLETE BEAM DIAGNOSTIC SYSTEM FOR HCI AT IUAC TRIUMF

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Results :

5 10 15 20 25

 Developed indigenously a very compact diagnostic system. Current and Profile results match with NEC. • It can replace any conventional beam diagnostic components in the beam line. \circ Low cost, high accuracy (~10pA), high reliability and simplicity are the figures of merit of this system.

Beam Parameters Measurement: o Beam Current, Beam Profile and Beam Position Beam Spot Size and Bunch Length • Beam Energy

and Position Measurement Display

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b 2.5 Times Scale